

## Freeform Search

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<b>Database:</b>	US Pre-Grant Publication Full-Text Database US Patents Full-Text Database US OCR Full-Text Database EPO Abstracts Database JPO Abstracts Database Derwent World Patents Index IBM Technical Disclosure Bulletins
<b>Term:</b>	(thermal test\$3 or thermal cycling) and (carousel or circular chamber or circular holder or circular carrier) and (electronic component or
<b>Display:</b>	<input type="text" value="10"/> Documents in <b>Display Format:</b> <input type="text" value="-"/> Starting with Number <input type="text" value="1"/>
<b>Generate:</b> <input type="radio"/> Hit List <input checked="" type="radio"/> Hit Count <input type="radio"/> Side by Side <input type="radio"/> Image	

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### Search History

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DATE: Thursday, June 16, 2005    [Printable Copy](#)    [Create Case](#)

<u>Set</u> <u>Name</u> <u>Query</u>	<u>Hit</u> <u>Count</u>	<u>Set</u> <u>Name</u> result set
side by side		
<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=ADJ</i>		
<u>L36</u> (thermal test\$3 or thermal cycling) and (carousel or circular chamber or circular holder or circular carrier) and (electronic component or chip or IC or integrated circuit or DUT or device under test)	55	<u>L36</u>
<u>L35</u> (thermal test\$3 or thermal cycling) and (carousel) and (electronic component or chip or IC)	41	<u>L35</u>
<u>L34</u> (thermal test\$3) same (carousel) same (electronic component or IC or chip)	0	<u>L34</u>
<u>L33</u> (thermal\$2 cycling) same (carousel) same (electronic component or intergrated circuit or IC or device under test or DUT or chip)	0	<u>L33</u>
<i>DB=USPT; PLUR=YES; OP=ADJ</i>		
<u>L32</u> L31 and (carousel)	8	<u>L32</u>
<u>L31</u> (thermal\$2 cycling) same (biological sample\$1)	28	<u>L31</u>
<u>L30</u> (carousel) same (central hole)	15	<u>L30</u>
<u>L29</u> (carousel) same (heat\$3) same (cool\$3) same (receptacle\$1) and (central opening or central hole or central aperture)	0	<u>L29</u>
<u>L28</u> (sample holder) same (heat\$3) same (cool\$3) same (receptacle\$1)	2	<u>L28</u>

<u>L27</u>	cool\$3 through central hole	0	<u>L27</u>
<u>L26</u>	cool\$3 through central opening	1	<u>L26</u>
<u>L25</u>	3616264.pn.	1	<u>L25</u>
<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=ADJ</i>			
<u>L24</u>	L10 and (biological sample\$1)	18	<u>L24</u>
<u>L23</u>	thermocouple electrical resist\$5	11	<u>L23</u>
<i>DB=PGPB; PLUR=YES; OP=ADJ</i>			
<u>L22</u>	L21 and (resistance)	1	<u>L22</u>
<u>L21</u>	L20 and "wire thermocouple"	1	<u>L21</u>
<u>L20</u>	20050069016	1	<u>L20</u>
<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=ADJ</i>			
<u>L19</u>	measur\$4 thermocouple resist\$4	9	<u>L19</u>
<u>L18</u>	thermocouple wire resist\$4 or thermocouple lead resist\$4	11	<u>L18</u>
<u>L17</u>	L16 and (liner or lining)	46	<u>L17</u>
<u>L16</u>	L15 and (wear or worn or deterioration or damage or leak\$4 or flaw)	264	<u>L16</u>
<u>L15</u>	L14 same (temperature or thermal or voltage)	680	<u>L15</u>
<u>L14</u>	thermocouple resistance	725	<u>L14</u>
<u>L13</u>	resistance of thermocouple	0	<u>L13</u>
<u>L12</u>	electrical resistance of thermocouple	0	<u>L12</u>
<u>L11</u>	(circular test chamber or round test chamber or carousel) and (central opening or central hole or central duct) same (heat\$3) same (cool\$3)	7	<u>L11</u>
<u>L10</u>	L9 and (central opening or central hole or central aperture or central duct)	162	<u>L10</u>
<u>L9</u>	(circular test chamber or round test chamber or carousel) and (heat\$3) and (cool\$3)	1770	<u>L9</u>
<u>L8</u>	L7 and (test chamber or test container or carousel) and (heat\$3) and (cool\$3)	48	<u>L8</u>
<u>L7</u>	L6 and (DUT or device under test)	3791	<u>L7</u>
<u>L6</u>	324/\$.ccls.	139658	<u>L6</u>
<u>L5</u>	L4 and (test coupon or daisy chain)	1	<u>L5</u>
<u>L4</u>	(circular test chamber or round test chamber or carousel) same (heat\$3) same (cool\$3)	240	<u>L4</u>
<u>L3</u>	(test coupon) same (chamber or carousel or circular\$2 mount\$3)	103	<u>L3</u>
<i>DB=USPT; PLUR=YES; OP=ADJ</i>			
<u>L2</u>	L1 and (cool\$3 or fan)	0	<u>L2</u>
<u>L1</u>	5246665.pn.	1	<u>L1</u>

END OF SEARCH HISTORY